Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/617,655	KACHI ET AL.
Examiner	Art Unit
Thien F. Tran	2811

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SEARCHED						
Class	Subclass	Date	Examiner			
257	13 79-84 97-99	2/2/2006	ТТ			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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